

CMOS 12-Bit Successive Approximation ADC

AD7582

FEATURES

12-Bit Successive Approximation ADC
Four High Impedance Input Channels
Analog Input Voltage Range of 0 to +5V with Positive
Reference of +5V
Conversion Time of 100µs per Channel
No Missed Codes Over Full Temperature Range
Low Total Unadjusted Error ±1LSB max
Autozero Cycle for Low Offset Voltage

GENERAL DESCRIPTION

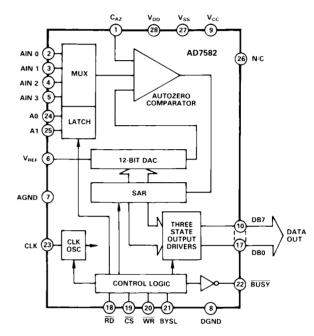
Monolithic Construction

The AD7582 is a medium speed, 4-channel 12-bit CMOS A/D converter which uses the successive approximation technique to provide a conversion time of 100 μ s per channel. An auto-zero cycle occurs at the start of each conversion resulting in very low system offset voltages, typically less than 100 μ V. The device is designed for easy microprocessor interface using standard control signals; \overline{CS} (decoded device address), \overline{RD} (\overline{READ}) and \overline{WR} (\overline{WRITE}). The 4-channel input multiplexer is controlled via address inputs A0 and A1.

Conversion results are available in two bytes, 8LSB's and 4MSB's, over an 8-bit three state output bus. Either byte can be read first. Two converter busy flags are available to facilitate polling of the converter's status.

The analog input voltage range is 0V to +5V when using a reference voltage of +5V. The four analog inputs are all high impedance inputs with tight channel-to-channel matching-typically 0.1LSBs.

FUNCTIONAL BLOCK DIAGRAM



PRODUCT HIGHLIGHTS

- 1. The AD7582 is a complete 4 channel 12-bit A/D converter in either a 28-pin DIP or 28-terminal surface mount package requiring only a few passive components and a voltage reference.
- 2. Autozero cycle realizes very low offset voltages, typically 100 u.V.
- The four channel input multiplexer (user addressable) features high input impedance and excellent channel-to-channel matching.
- 4. Standard microprocessor control signals to allow easy interfacing to most popular 8- and 16-bit microprocessors.

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$\textbf{AD7582} \textbf{---SPECIFICATIONS} \ \, \overset{(V_{DD}}{\text{oll specifications }} \, \overset{(V_{DD}}{\text{oll specifications }} \, \overset{+}{\text{to }} \, \overset{+}{\text{to }} \, \overset{+}{\text{to }} \, \overset{-}{\text{to }} \, \overset{-}{\text{to }} \, \overset{+}{\text{to }} \, \overset{-}{\text{to }} \, \overset{+}{\text{to }} \, \overset{-}{\text{to }} \, \overset{+}{\text{to }} \,$

Parameter	K Version ¹	B Version ¹	T Version ¹	Units	Conditions/Comments
ACCURACY					·
Resolution	12	12	12	Bits	
Total Unadjusted Error ²	± 1	± 1	± 1	LSB max	All channels, AIN0-AIN3
Differential Nonlinearity	± 1	± i	± i	LSB max	No missing codes guaranteed
Full Scale Error (Gain Error) ³	± 1/4	± 1/4	± 1/4	LSB max	All channels, AIN0–AIN3
Tun Scale Error (Gain Error)		- 1/4		Lobinax	Full Scale TC is typically 5ppm/°C
Offset Error ³	± 1/4	± 1/4	± 1/4	LSB max	All channels, AIN0–AIN3
Chisci Eiror			± 1/4	Lobinax	Offset Error TC is typically 5ppm/°C
Channel to Channel Mismatch ³	± 1/4	± 1/4	± 1/4	LSB max	Onset Error Te is typically 5ppin/ e
ANALOG INPUTS					
Analog Input Range	0 to +5	0 to +5	0 to + 5	v	$V_{REF} = +5.0V$
C _{AIN} , On Channel Input Capacitance	8	8	8	pF typ	KEP
I _{AIN} , Input Leakage Current	"	"		Pr typ	AIN0-AIN3; 0 to +5V
+ 25°C	10	10	10	nA max	11110-11113,010 + 31
		1			
T_{\min} to T_{\max}	100	100	100	nA max	
REFERENCE INPUT		1	1		
V _{REF} (For Specified Performance)	+ 5	+ 5	+ 5	V	± 5%
V _{REF} Range	+4 to +6	+4 to +6	+4 to +6	V	Degraded transfer accuracy
V _{REF} Input Reference Current	1.0	1.0	1.0	mA max	$V_{REF} = +5.0V$
OWER SUPPLY REJECTION				1	
-	± 1/8	± 1/8	± 1/8	LSB typ	$V_{DD} = +14.25V \text{ to } +15.75V$
$V_{ m DD}$ Only	÷ 1/6	- 1/8	- 1/8	Lob typ	$V_{DD} = +14.23 \text{ to } +13.73 \text{ V}$ $V_{SS} = -5 \text{ V}$
V Only	+ 1/9	+1/9	1 + 1/9	1 CD	$V_{SS} = -5V$ $V_{SS} = -4.75V \text{ to } -5.25V$
V_{SS} Only	± 1/8	± 1/8	± 1/8	LSB typ	$V_{SS} = -4.75 V \text{ to } -5.25 V$ $V_{DD} = +15 V$
					V _{DD} = +13V
OGIC INPUTS					
\overline{RD} (Pin 18), \overline{CS} (Pin 19), \overline{WR} (Pin 20)					
BYSL (Pin 21), A0 (Pin 24), A1 (Pin 25)		1			
VII. Input Low Voltage	+0.8	+0.8	+0.8	V max	$V_{CC} = +5V \pm 5\%$
V _{IH} Input High Voltage	+ 2.4	+ 2.4	+2.4	V min	
I _{IN} Input Current					
+ 25°C	±1	± 1	± 1	μA max	$V_{IN} = 0$ to V_{CC}
T_{min} to T_{max}	+ 10	+ 10	+ 10	μA max	
C _{IN} Input Capacitance ³	10	10	10	pF max	
CLK (Pin 23)	1			•	
V _{IL} , Input Low Voltage	+0.8	+ 0.8	+0.8	V max	$V_{CC} = +5V \pm 5\%$
V _{IH} , Input High Voltage	+ 3.0	+ 3.0	+ 3.0	V min	1 1 2 1 2 7 2 7 7
I _{II.} , Input Low Current	± 10	± 10	± 10	μA max	
	+ 1.5	+1.5	+1.5	mA max	
I _{IH} , Input High Current	71.5	T 1.3	T 1.5	IIII III III AX	
LOGIC OUTPUTS	1		i		
DB0-DB7 (Pins 10-17), \overline{BUSY} (Pin 22) ⁴			1	1	
V _{OL} , Output Low Voltage	+0.4	+0.4	+0.4	V max	$V_{CC} = +5V \pm 5\%, I_{SINK} = 1.6 \text{mA}^4$
VOH, Output High Voltage	+4.0	+4.0	+4.0	V min	$V_{CC} = +5V \pm 5\%, I_{SOURCE} = 200 \mu A$
Floating State Leakage Current			1		
(Pins 10–17)	± 1	± 1	± 1	μA max	$V_{OUT} = 0V \text{ to } V_{CC}$
Floating State Output Capacitance	15	15	15	pF max	
CONVERSION TIME ⁵	1		1		
With External Clock	100	100	100	μs min	$f_{CLK} = 140kHz$
	1	50/100	50/100	μs min/max	Using recommended clock components
With Internal Clock, $T_A = +25^{\circ}C$	50/100	30/100	30/100	µs mm/max	as shown in Figure 6.
	ļ	 			as shown in Figure 0.
OWER REQUIREMENTS ⁶		1	1	1	
V_{DD}	+ 15	+ 15	+ 15	VNOM	± 5% for specified performance
V_{SS}	-5	-5	-5	VNOM	± 5% for specified performance
v_{cc}	+ 5	+ 5	+ 5	VNOM	± 5% for specified performance
I _{DD}	7.5	7.5	7.5	mA max	Typically 4mA with $V_{DD} = +15\text{V}$
I _{SS}	7.5	7.5	7.5	mA max	Typically 3mA with $V_{SS} = -5V$
I_{CC}	100	100	100	μA typ	$V_{IN} = V_{IL} \text{ or } V_{IH}$
*C.	1.0	1.0	1.0	mA max	· III · III · III

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NOTES

Temperature Range as follows: K, B Versions; -40°C to +85°C

T Version; -55°C to +125°C

Includes Full Scale Error, Offset Error and Relative Accuracy.

Guaranteed by Design, not Production tested.

Includes But St (pin 22) is 1.0 milliamp.

Conversion Time includes autozero cycle time.

Power supply current is measured when AD7582 is inactive i.e., \overline{WR} - \overline{RD} - \overline{CS} - \overline{BUSY} - Logic HIGH.

Specifications subject to change without notice.

TIMING SPECIFICATIONS 1 (v_{dd} = + 15 \text{V}, v_{cc} = + 5 \text{V}, v_{ss} = - 5 \text{V}, v_{\text{REF}} = + 5 \text{V})

Parameter	Limit at +25°C (All Grades)	Limit at T _{min} , T _{max} (K & B Grades)	Limit at T_{min} , T_{max} (T Grade)	Units	Conditions/Comments
t_1	0	0	0	ns min	CS to WR Setup Time
$t_2(INT)^2$	200	240	280	ns min	WR Pulse Width (Internal Clock Operation)
$t_2(EXT)^2$	10	10	10	μs min	WR Pulse Width (External Clock Operation)
t ₃	0	0	0	ns min	CS to WR Hold Time
t ₄	130	160	200	ns typ	
	200	250	300	ns max	WR to BUSY Propagation Delay
5	0	0	0	ns min	A0, A1 Valid to WR Setup Time
6	20	20	20	ns min	A0, A1 Valid to WR Hold Time
t ₇	0	0	0	ns min	BUSY to CS Setup Time
8	0	0	0	ns min	CS to RD Setup Time
9	200	240	280	ns min	RD Pulse Width
10	0	0	0	ns min	$\overline{ ext{CS}}$ to $\overline{ ext{RD}}$ Hold Time
11	50	50	50	ns min	BYSL to RD Setup Time
12	0	0	0	ns min	BYSL to RD Hold Time
13	150	180	200	ns typ	
	200	240	280	ns max	RD to Valid Data (Bus Access Time)
4	20	20	20	ns min	RD to Three State Output
	130	150	150	ns max	(Bus Relinquish Time)

NOTES

Specifications subject to change without notice.

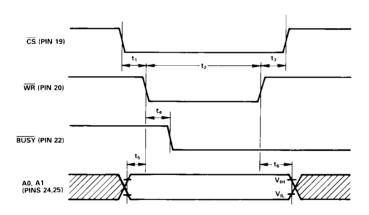


Figure 1. Start Cycle Timing

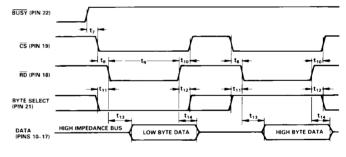


Figure 2. Read Cycle Timing

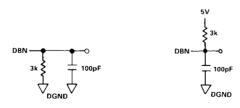


Figure 3. Load Circuits for Access Time Test (t₁₃)

a. High-Z to V_{OH}

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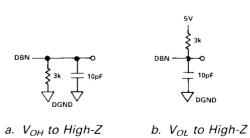


Figure 4. Load Circuits for Output Float Delay Test (t₁₄)

b. High-Z to V_{OL}

¹Timing Specifications are guaranteed by Design, not Production tested. All input control signals are

specified with $t_r = t_f = 20 \text{ns} (10\% \text{ to } 90\% \text{ of } + 5\text{V})$ and timed from a voltage level of + 1.6V. Data is timed from

 $V_{\rm IH}, V_{\rm IL}$ or $V_{\rm OH}, V_{\rm OL}$.

 $^{^2}$ When using an external clock source the \overline{WR} pulse width must be extended to provide the minimum auto-zero cycle time of 10 µs. See "External Clock Operation".

 $^{^{3}}t_{13}$ is measured with the load circuits of Figure 3 and defined as the time required for an output to cross 0.8V or 2.4V.

 $^{^4}$ t₁₄ is defined as the time required for the data lines to change 0.5V when loaded with the circuits of Figure 4.

ABSOLUTE MAXIMUM RATINGS*

$(T_A = +25^{\circ}C \text{ unless otherwise stated})$
V_{DD} to DGND
V_{SS} to DGND +0.3V, -7V
AGND to DGND $-0.3V$, V_{REF} $+0.3V$
V_{CC} to DGND0.3V, V_{DD} +0.3V
V_{REF} to AGND0.3V, V_{DD} +0.3V
AIN (0-3) to AGND $\dots \dots \dots$
Digital Input Voltage to DGND
(Pins 18-21, 23-25) $-0.3V$, $V_{DD} + 0.3V$
Digital Output Voltage to DGND
(Pins 10-17, 22) $-0.3V$, $V_{DD} + 0.3V$
Operating Temperature Range
Commercial (K Version)40°C to +85°C
Industrial (R Version) -40°C to ±85°C

Extended (T Version) -55° C to $+125^{\circ}$ C ORDERING GUIDE

M odel ¹	Temperature Range	Total Unadjusted Error T _{MIN} -T _{MAX}	Package Option ²
AD7582KN	$-40^{\circ}\text{C to} + 85^{\circ}\text{C}$	±1LSB	N-28
AD7582BQ	-40°C to $+85^{\circ}\text{C}$	$\pm 1LSB$	Q-28
AD7582TQ	-55° C to $+125^{\circ}$ C	±1LSB	Q-28
AD7582KP	-40°C to $+85$ °C	± 1LSB	P-28A

NOTES

Storage Temperature65°C to	+ 150°C
Junction Temperature	+ 150°C
DIP Package, Power Dissipation	875mW
θ_{JA} Thermal Impedance	75°C/W
Lead Temperature, Soldering (10sec)	+ 260°C
Cerdip Package, Power Dissipation	000mW
θ_{JA} Thermal Impedance	51°C/W
Lead Temperature, Soldering (10sec)	
PLCC Package, Power Dissipation	500mW
θ_{JA} Thermal Impedance	80°C/W
Lead Temperature, Soldering	
Vapor Phase (60sec)	+215°C
Infrared (15sec)	+210°C

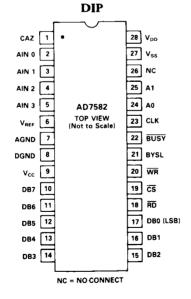
*Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

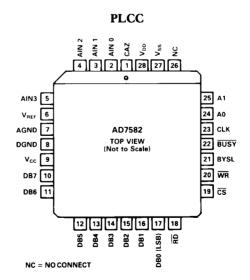
ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V, which readily accumulate on the human body and on test equipment, can discharge without detection. Although these devices feature proprietary ESD protection circuitry, permanent damage may still occur on these devices if they are subjected to high energy electrostatic discharges. Therefore, proper precautions are recommended to avoid any performance degradation or loss of functionality.



PIN CONFIGURATIONS

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¹To order MIL-STD-883, Class B processed parts, add /883B to part number. Contact your local sales office for military data sheet.

²N = Plastic DIP; Q = Cerdip, P = Plastic Leaded Chip Carrier.

PIN FUNCTION DESCRIPTION

THEF	ACTION DESCRI	11014
PIN	MNEMONIC	DESCRIPTION
1	CAZ	Autozero Capacitor Input. Connect other side of capacitor to AGND.
2	AIN 0	Analog Input, channel 0
3	AIN 1	Analog Input, channel 1
4	AIN 2	Analog Input, channel 2
5 6	AIN 3 V _{REF}	Analog Input, channel 3 Voltage reference input. The AD7582 is specified with $V_{REF} = +5.0V$.
7	AGND	Analog Ground
8	DGND	Digital Ground
9	v_{cc}	Logic Supply. For $V_{CC} = +5V$ digital inputs and outputs are TTL compatible.
10-17		Three state data outputs. They become active when \overline{CS} & \overline{RD} are brought low. Individual pin function is dependent upon the Byte Select (BYSL) input.

DATA BUS OUTPUT, \overline{CS} & \overline{RD} = LOW

	BYSL = HIGH	BYSL = LOW
Pin 10	BUSY ¹	DB7
Pin 11	LOW ²	DB6
Pin 12	LOW ²	DB5
Pin 13	LOW ²	DB4
Pin 14	DB11 (MSB)	DB3
Pin 15	DB10	DB2
Pin 16	DB9	DB1
Pin 17	DB8	DB0(LSB)

¹BUSY (Pin 10) is a converter status flag and is HIGH during a conversion. ²Pins 11-13 output a logic LOW when BYSL is HIGH.

DB11-DB0 are the 12-bit conversion results, DB11 is the MSB.

18	RD	READ input. This active LOW signal, in combination with CS, is used to enable the output data three-
		state drivers.

¹⁹ CS CHIP SELECT Input. Decoded device address, active LOW. Used in combination with either RD or

channel. When the AD7582 internal clock is used, the minimum WR pulse width is t2 (INT). When an external clock source is used, the minimum \overline{WR} pulse width must be extended to include the autozero cycle time. For external clock operation, the minimum \overline{WR} pulse width is t2 (EXT).

BYSL BYSL BYTE SELECT. This control input determines whether the high or low byte of data is placed on the output data bus during a data READ operation (\overline{CS} & \overline{RD} \text{LOW}). See description of pins 10-17.

BUSY indicates converter status. \overline{BUSY} is \text{LOW} during conversion, otherwise \overline{BUSY} is held at a logic HIGH.

23 CLK CLOCK Input for internal/external clock operation.

 $Internal: Connect \, R_{CLK} \, and \, C_{CLK1} / C_{CLK2} \, timing \, components. \, See \, Figure \, 6 \, and \, Figure \, 7.$

External: Connect external 74HC compatible clock source as shown in Figure 8.

24 AO Address Input AO. See pin 25 description.

Al Address Input A1. Address inputs AO and A1 select the input channel to be converted. The address input latch is transparent when \overline{CS} & \overline{WR} are LOW. The address inputs are latched by \overline{WR} returning HIGH.

Al	A0	CHANNEL SELECTED
0	0	AIN 0
0	1	AIN 1
1	0	AIN 2
1	1	AIN 3

N/C No connect pin.
 V_{SS} Negative supply, -5V.
 V_{DD} Positive supply, +15V.

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WRITE Input. This active LOW signal, in combination with \overline{CS} , is used to start a new conversion on a selected channel. When the AD7582 internal clock is used, the minimum \overline{WR} pulse width is t2 (INT). When an external

Operating Information

OPERATIONAL DIAGRAM

An operational diagram for the AD7582 is shown in Figure 5. The only passive components required are the autozero capacitor C_{AZ} and timing components R_{CLK} , C_{CLK1} & C_{CLK2} for the internal clock oscillator. If the AD7582 is to be used with an external clock source, then only C_{AZ} is required. Individual pin functions are described in detail on the previous page.

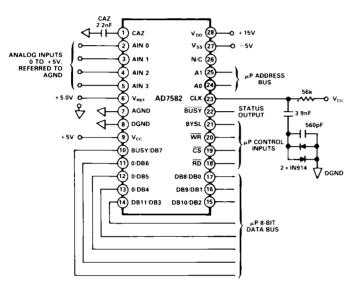


Figure 5. AD7582 Operational Diagram

INTERNAL CLOCK OPERATION

The clock circuitry for internal clock operation is shown in Figure 6 and the AD7582 operating waveforms are shown in Figure 7.

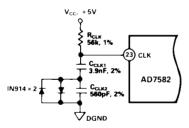


Figure 6. Circuitry Required for Internal Clock Operation

BUSY

A0. A1 INPUTS
LATCHED

A0. A1 INPUTS
LATCHED

AUTOZERO
CYCLE TIME

DB11 DB10 DB9 DB8 DB7 DB6 DB5 DB4 DB3 DB2 DB1 DB0
(MSB)

DECISION POINTS

Figure 7. Operating Waveforms - Internal Clock

*t₂(INT) IS THE MINIMUM WRITE PULSE WIDTH WHEN USING INTERNAL CLOCK. SEE TIMING SPECIFICATIONS.

Between conversions ($\overline{BUSY} = HIGH$) the AD7582 is in the autozero cycle. When \overline{WR} goes LOW (with \overline{CS} LOW) to start a new conversion, the input multiplexer is switched to the selected channel N, via address inputs A0, A1. The autozero capacitor C_{AZ} now charges to AIN N–V_{OS} where V_{OS} is the input offset voltage of the autozero comparator.

A minimum time of 10 µs is required for this autozero cycle. In applications using the internal clock oscillator, it is not necessary for WR to remain LOW for this period of time since it is automatically provided by the AD7582. This is achieved by switching a constant current load across the clock capacitors, C_{CLK1} and C_{CLK2}, causing the voltage at the CLK input pin to slowly decay from V_{CC} . This occurs after \overline{WR} returns HIGH; \overline{WR} returning HIGH also latches the multiplexer address inputs A0, A1 (see Figure 7). The Schmitt trigger circuit monitoring the voltage on the CLK input ends the autozero cycle when its LOW input trigger level is reached. At this point, the constant current load across the clock capacitors is removed allowing them to charge towards V_{CC} via R_{CLK}. When the voltage at the CLK input reaches the HIGH trigger level, the constant current load is replaced across C_{CLK1} and C_{CLK2} . The MSB decision is made when the LOW trigger level is reached. This cycle repeats itself 12 times to provide 12 clock pulses for the conversion cycle. The circuit arrangement of Figure 6 provides the relatively slow autozero cycle time at the beginning of a conversion while allowing the clock oscillator to speed up once the autozero cycle is complete.

EXTERNAL CLOCK OPERATION

For external clock operation $R_{\rm CLK}, C_{\rm CLK1}$ and $C_{\rm CLK2}$ are discarded and the CLK input is driven from a 74HC compatible clock source. The mark/space ratio of the external clock can vary from 40/60 to 60/40. The AD7582 WR pulse width must now be extended to provide the minimum autozero cycle time of 10μs since this is no longer provided automatically by the AD7582. Referring to the operating waveforms of Figure 9, the minimum \overline{WR} pulse width when using an external clock source is t_2 (EXT). Multiplexer address inputs A0 and A1, in addition to the \overline{CS} input must now remain valid for the external \overline{WR} pulse width. One approach to stretching the available μP signals is shown in the general 8-bit µP interface circuit of Figure 20. It is not necessary to synchronize the external clock source with the extended WR pulse width, the MSB decision being made on the second falling edge of the clock input after the WR input returns HIGH.

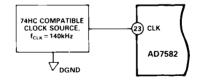


Figure 8. External Clock Operation

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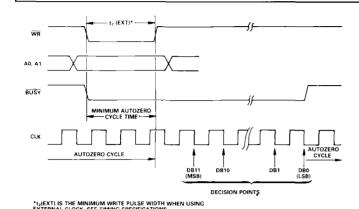


Figure 9. Operating Waveforms - External Clock

READING DATA

The 12-bit conversion data plus a converter status flag are available over an 8-bit wide data bus. Data is transferred from the AD7582 in right-justified format (i.e., the LSB is the most right-hand bit in a 16-bit word). Two READ operations are required, the Byte Select (BYSL) input determining which byte–8 least significant bits or 4 most significant bits plus status flag—is to be read first.

Since the AD7582 uses the successive approximation register (SAR) to hold conversion results (refer to Functional Diagram), it is necessary to wait until a conversion is finished before reading valid 12-bit data. Executing a READ instruction (HIGH or LOW byte) to the AD7582 while a conversion is in progress will place the existing contents of the SAR onto the data bus. Three different approaches can ensure valid 12-bit data is available for reading.

- 1. Insert a software delay greater than the ADC conversion time between the conversion start instruction and the data read instructions.
- 2. At user-defined intervals after a conversion start instruction, poll the internal converter status flag, BUSY. This signal is available on pin 10 during a HIGH byte READ instruction and is the most left-hand bit in a 16-bit right-justified word. The status bit can be shifted into a microprocessor's accumulator-carry position for testing (BUSY is HIGH during conversion).
- 3. Use the externally available BUSY (pin 22) signal as an interrupt to the microprocessor. This signal is LOW during a conversion and returns HIGH at conversion end.

Executing a WRITE instruction while conversion is in progress will restart the conversion.

COMPONENT SELECTION

- 1. Autozero Capacitor, CAZ
- The autozero capacitor must be a low leakage, low dielectric absorption type such as polystyrene, polypropylene or teflon. To minimize noise connect the outside foil of C_{AZ} to AGND (pin 7), the analog system ground. C_{AZ} should be 2,200pF.
- 2. Clock Oscillator Components, R_{CLK}, C_{CLK1} and C_{CLK2} Clock pulses are generated by the action of series connected capacitors, C_{CLK1} and C_{CLK2} charging through an external resistor R_{CLK} and discharging through an internal switch. Nominal conversion time versus temperature for the recommended R_{CLK} and C_{CLK1}/C_{CLK2} combination is shown in Figure 10. Due to process variations, the actual operating frequency for this R_{CLK} and C_{CLK1}/C_{CLK2} combination can vary from device to device by up to 20%. For this reason, Analog Devices recommends using an external clock in the following situations:
 - a. Applications requiring a conversion time which is within 20% of 100μs, the maximum conversion time for specified accuracy (a 140kHz clock frequency gives a 100μs conversion time).
 - Applications which cannot accommodate conversion time differences which may occur due to unit clock frequency variations or temperature variations.

It is possible to replace the fixed $R_{\rm CLK}$ resistor with a 50k potentiometer in series with a fixed $22k\Omega$ resistor to allow individual adjustment of internal clock frequency. Reducing the value of $R_{\rm CLK}$ from 56k to 47k decreases the conversion time by typically $12\mu s$.

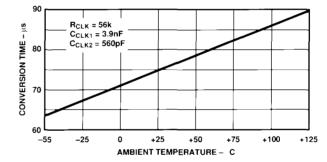
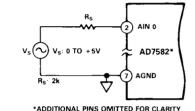


Figure 10. Typical Conversion Time vs. Temperature Using Internal Clock

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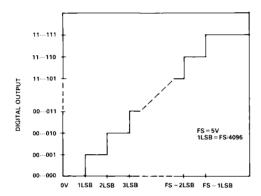
APPLYING THE AD7582

The high input impedance of the analog channels, AIN0–AIN3, allows simple analog interfacing. Zero to +5V signal sources can be connected directly to the analog input channels without additional buffering for source impedances up to $5k\Omega$ (see Figure 11). The input/output transfer characteristic and transition points for this input signal range are shown in Figure 12 and Table I respectively. The designed transition points on the AD7582 transfer characteristic occur on integer multiples of 1LSB. The output code is Natural Binary with 1LSB = (F.S.) (1/4096) = (5/4096)V = 1.22mV.



*ADDITIONAL PINS OMITTED FOR CLARITY, ONLY CHANNEL 0 SHOWN

Figure 11. Unipolar 0 to +5V Operation

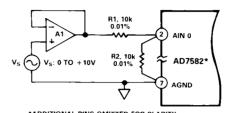


ANALOG INPUT, ANY CHANNEL
Figure 12. Ideal Input/Output Transfer Characteristic for
Unipolar Circuit of Figure 11

Table I. Transition Points for Unipolar 0 to \pm 5V Operation

	Analog Input, Volts		Digital Output		
	0.00122		000 001	٦	
,	0.00244	T	000 010	٦	J
1	2.49878	7	011 111	1	ر
	2.50000		100 000		
,	2.50122	T	100 001	لر	ر
1	~ 4.99756	7	111 110	7	۰
	4.99878		111 111		

Signal ranges other than 0 to +5V are easily accommodated by using resistor divider networks to produce 0 to +5V signal ranges at the AD7582 input pins. Figure 13 shows a divider network on channel 0 to allow an AIN 0 signal range of 0 to +10V. The input resistors must be selected to match within 0.01% and should be the same type and from the same manufacturer so that their temperature coefficients match. Note that since the source impedance has not been included in the resistor divider ratio, it must now be as low as possible. For Figure 13 with a source impedance of 0.5Ω the maximum error across the network is approximately 0.5LSB. The LSB size is (F.S.)(1/4096) = (10/4096)V = 2.44mV.



*ADDITIONAL PINS OMITTED FOR CLARITY, ONLY CHANNEL 0 SHOWN

Figure 13. Unipolar 0 to + 10V Operation

Bipolar signal ranges of -5V to +5V are accommodated by referencing the resistor divider network to V_{REF} as shown in Figure 14 for channel 0. With the resistor values shown, the signal source must be capable of sinking 0.5mA. The input/output transfer characteristic and transition points for this $\pm 5V$ signal range are shown in Figure 15 and Table II respectively. The output code is Offset Binary with an LSB size of (F.S.)(1/4096) = (10/4096)V = 2.44mV.

With an analog input (V_S) of -1.22mV, the input offset voltage of A1 should be adjusted until the ADC output flickers between 0111 1111 1111 and 1000 0000 0000. Alternatively the -1/2LSB signal offset can be included in the signal conditioning electronics.

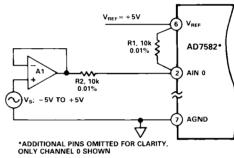


Figure 14. Bipolar -5V to +5V Operation

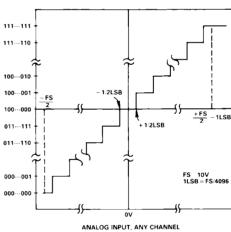


Figure 15. Ideal Input/Output Transfer Characteristic for Bipolar Circuit of Figure 14

Table II. Transition Points for Bipolar - 5V to + 5V Operation

	Analog Input, Volts		Digital Outpu	ıt
	-4.99878		000 001	
	_ - 4.99634	لم	000 010	~
1	~ −0.00122	Τ	100 000	า
إ	+0.00122	لم	100 001	لر
1	~ +4.99389	7	111 110	7
	+4.99634	Ì	111 111	

Applications

Power Supply Decoupling: All power supplies to the AD7582 should be bypassed with either $10\mu\text{F}$ tantulum or electrolytic capacitors. To ensure good high frequency performance, each capacitor should be bypassed with an $0.01\mu\text{F}$ disc ceramic capacitor. All capacitors should be placed as close as possible to the AD7582.

Reference Circuit: Figure 16 shows how to configure an AD584LH to produce a reference voltage of 5.00V. R2 provides a typical adjustment range of ±75mV. The AD584LH will contribute less than 1LSB of gain error over the commercial temperature range.

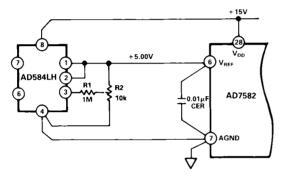


Figure 16. AD584LH as Reference Generator

Transient currents flow at the V_{REF} input during a conversion. To avoid dynamic errors place a $0.01\mu F$ disc ceramic from the V_{REF} pin to AGND.

Proper Layout: Layout for a printed circuit board should ensure that digital and analog signal lines are separated as much as possible. In particular, care should be taken not to run any digital track alongside an analog signal track or close to the autozero capacitor. The analog inputs, the reference input and the autozero input should be screened by AGND.

A single point analog ground separate from the logic system ground should be established at pin 7 (AGND) or as close as possible to the AD7582. This single point analog ground should be connected to the digital system ground, to which pin 8 (DGND) is connected, at one point only and as close to the AD7582 as possible. The autozero capacitor, bypass capacitors for the reference input and the analog supplies, AIN commons and any input signal screening should be returned to the analog ground point. Low impedance analog and digital power supply common returns are essential to low noise operation of the ADC and the foil width for these tracks should be as wide as possible.

Noise: Input signal leads to AIN 0-3 and signal return leads from AGND (pin 7) should be kept as short as possible to minimize input noise coupling. In applications where this is not possible, a shielded cable between source and ADC is recommended. Also since any potential difference in grounds between the signal source and ADC appears as an error voltage in series with the input signal, attention should be paid to reducing the ground circuit impedances as much as possible.

In applications where the AD7582 data outputs are connected to a continuously busy (and noisy) microprocessor bus it is possible to get LSB errors in conversion results. These errors are due to feedthrough from the microprocessor bus to the autozero comparator. The problem exists only for ceramic package versions of the AD7582.

Stopping bus activity during a conversion eliminates this problem. Alternatively the AD7582 can be isolated from the microprocessor bus by means of three-state buffers.

Microprocessor Interfacing

MICROPROCESSOR INTERFACING

When the AD7582 is used with its own internal clock oscillator, microprocessor interfacing is straightforward and requires at most a few external gates (see Figures 17 through 19, 21 and 22). When the AD7582 is used with an external clock source, additional circuitry is required to extend the μP control signals (see Figure 20).

MC6800, MC6809 and 6502 MICROPROCESSORS

A typical interface to the AD7582 with any of the above microprocessors is shown in Figure 17. The decoder can be enabled high using VMA in 6800 systems or enabled low by NOR'ing ϕ_0 and ϕ_2 in 6502 systems or by NOR'ing E and Q in 6809 systems. Address lines A0, A1, and A2 of the 6800 have been tied to A0, A1 and BYSL respectively of the AD7582. Assuming the AD7582 is assigned a memory block starting at address 8000H, the input multiplexer is addressed as follows:

8000H	Channel (
8001H	Channel 1
8002H	Channel 2
8003H	Channel 3

A write instruction to one of these addresses will start a conversion of the selected channel. To read the conversion results, it is necessary only to bring control inputs \overline{CS} and \overline{RD} low. The BYSL input (tied to A2 of the μP) determines whether the data high or low byte is placed onto the 8-bit data bus. A read instruction to any one of the previous channel addresses will result in the low byte of data being transferred to the μP (BYSL = Low). Similarly a read instruction to any address having A2 HIGH and within the assigned memory block, e.g., 8004H, transfers the high byte of data to the μP . The converter status flag BUSY can be polled at intervals to check whether the present conversion has finished and valid 12-bit data is available. This is accomplished by the following instructions on the 6800:

LDA	Α	\$8004	
ASL	Α		
BCC		FETCH	

Load Flag from AD7582 Shift Flag into Carry Branch to Data Fetch Subroutine if BUSY is LOW

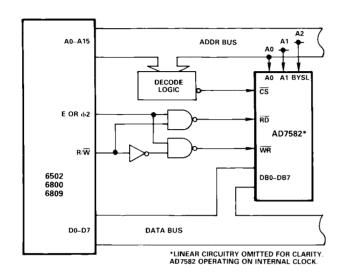


Figure 17. AD7582 - MC6800, 6809, 6502 Interface

8085A, Z80 MICROPROCESSORS

A typical interface to either of these microprocessors is shown in Figure 18. Not shown in the figure is the 8-bit latch required to demultiplex the 8085A common address/data bus. This interface uses slightly different low-level address decoding than the previous interface. Address lines A0, A1 & A2 of the μ P have been tied to BYSL, A0 & A1 respectively of the AD7582. This allows the 16-bit data move instructions on both the 8085A and the Z80 to be used when reading conversion results. Assuming the AD7582 is again assigned a memory block starting at address 8000H the input multiplexer is now addressed as follows:

8000H	Channel 0
8002H	Channel 1
8004H	Channel 2
8006H	Channel 3

A write instruction to one of these addresses will start a conversion of the selected channel. The 12-bit conversion results can be read (low byte first then high byte) by a single read instruction;

On the 8085A

LHLD 8000

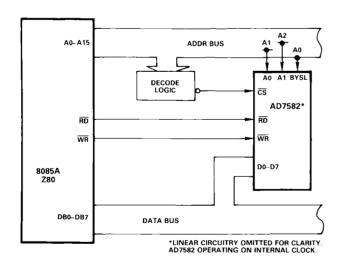


Figure 18. AD7582 - 8085A, Z80 Interface

moves the conversion results into register pair HL

On the Z80

LD BC, (8000)

moves the conversion results into register pair BC

MC68000, MC68008 MICROPROCESSOR

Figure 19 shows an AD7582-MC68000/MC68008 interface.

Address lines A1, A2 and A3 of the μP are connected to BYSL, A0 & A1 inputs respectively of the AD7582.

With the simple decoding logic shown in Figure 19, the AD7582 is decoded in a memory block from C000H to FFFFH. The input multiplexer is now addressed as follows:

C000H	Channel 0
C004H	Channel 1
C008H	Channel 2
C00CH	Channel 3

A write instruction to one of these addresses will start a conversion of the selected channel, i.e.,

starts a conversion of channel 1. When the conversion is complete, the μP acquires the result by reading from the AD7582, i.e,

This instruction places the conversion data in the D0 register of the μ P. Address register A2 should contain an odd-order address for the AD7582, e.g., \$C003.

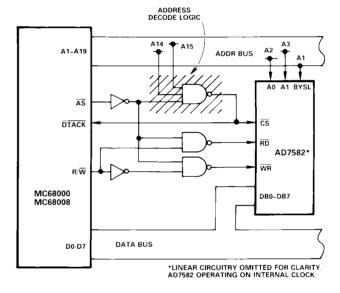


Figure 19. AD7582 - MC68000 MC68008 Interface

MICROPROCESSOR INTERFACE TO AD7582 WITH EXTERNAL CLOCK

Figure 20 shows the additional circuitry generally required to interface an 8-bit μP to the AD7582 operating from an external clock source. During a write operation, the 74121 monostable (one-shot) is triggered to latch the data (A0, A1 and \overline{CS}) in the 7477, a 4-bit bistable latch. The monostable timing components (not shown in Figure 20) should be chosen to provide an output pulse width corresponding to t_2 (EXT), the minimum autozero cycle time. To avoid any possibility of spurious triggering, the monostable should be enabled by a valid memory address signal. During a data read cycle, the 7477 latch is transparent and data is read normally. Note that the μP write and read cycle times are unaffected by the interface circuitry.

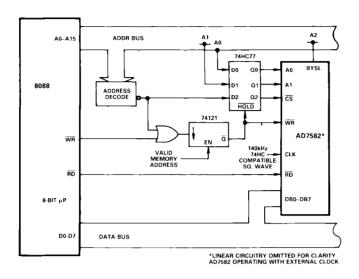


Figure 20. Interface to AD7582 Using External Clock

8088, 8086 MICROPROCESSORS

Figure 21 shows an AD7582-8088 interface.

Address lines A0, A1 and A2 are connected to BYSL, A0 and A1 inputs respectively of the AD7582. With the simple decoding shown in Figure 21 the AD7582 is decoded in a memory block from 4000H to 7FFFH. The input multiplexer is now addressed as follows:

4000H	Channel 0
4002H	Channel 1
4004H	Channel 2
4006H	Channel 3

A write instruction to one of these addresses will start a conversion of the selected channel, i.e,

starts a conversion of channel 2. When the conversion is finished the 8088 acquires the result by reading from the AD7582, i.e.,

places the conversion data in the accumulator.

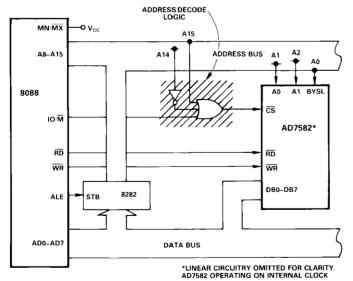


Figure 21. AD7582 - 8088 Interface

Figure 22 shows an AD7582-8086 interface. Address lines A1, A2 and A3 are connected to BYSL, A0 and A1 inputs respectively of the AD7582. The AD7582 is again decoded in a memory block from 4000H to 7FFFH. The input multiplexer is now addressed as follows:

4000H	Channel 0
4004H	Channel 1
4008H	Channel 2
400CH	Channel 3

A write instruction to one of these addresses will start a conversion of the selected channel, i.e,

starts a conversion of channel 2. When the conversion is finished, the 8086 acquires the result by reading from the AD7582 in two read cycles, i.e.,

MOV AL, 4000 MOV AH, 4002

places the conversion data in the accumulator.

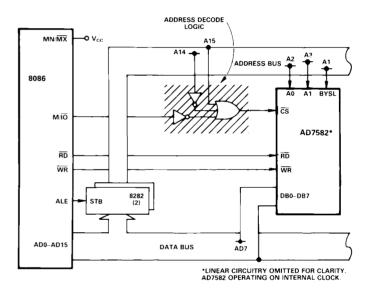


Figure 22. AD7582 - 8086 Interface

AD7582-AD585 SAMPLE-HOLD INTERFACE

Figure 23 shows an AD585 Sample-Hold Amplifier driving $A_{\rm IN1}$ of the AD7582. At a sampling frequency of 8kHz the maximum input signal frequency is 4kHz. The AD7582 is configured for bipolar operation to allow an input signal swing of \pm 5V. No clock components are shown for the AD7582 but the conversion time of the AD7582 should be adjusted for 100 microseconds. With an external hold capacitor of 100pF, the acquisition time for the sample-hold amplifier is 10 microseconds. The circuit operates from 0°C to +70°C.

To take a sample of the input, a WRITE instruction is executed to the AD7582 control inputs. The converter busy flag, BUSY, is driven low indicating that a conversion is in progress. The falling edge of this BUSY signal places the sample-hold amplifier into the HOLD mode "freezing" the input signal to the AD7582. After 100 microseconds the conversion is finished and the BUSY signal is brought high. This allows a time of 25 microseconds for the AD585 to come out of the hold mode and acquire the

input signal in time for the next sample. Between the end of one conversion and the start of the next, the conversion results must be read from the converter.

Careful circuit layout and power supply decoupling are necessary to obtain maximum performance from the system. Decoupling capacitors in the diagram are all $10\mu F$ electroytics in parallel with $0.01\mu F$ disc ceramics.

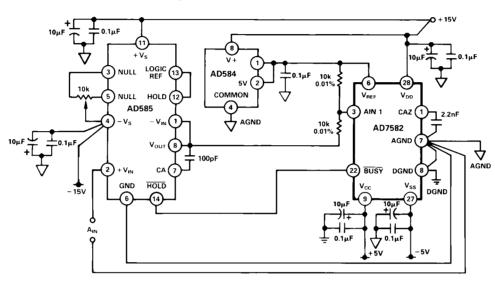


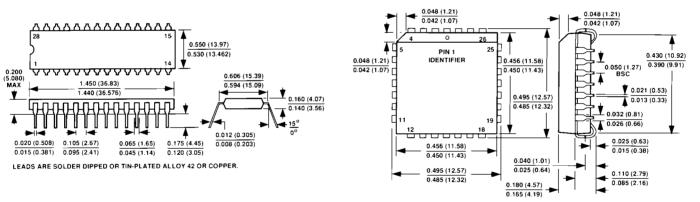
Figure 23. AD7582-AD585 Interface

MECHANICAL INFORMATION

Dimensions shown in inches and (mm).

28-Pin Plastic DIP (N-28)

28-Pin PLCC (P-28A)



28-Pin Cerdip (Q-28)

